Special Issue

Advances in Machine Learning for Intelligent Engineering Systems and Applications II

Message from the Guest Editors

The purpose of this Special Issue is to provide a forum for engineers, data scientists, researchers, and practitioners to present new academic research and industrial development on machine learning for engineering applications. The Special Issue gathers original research papers in the field, covering new theories, algorithms, systems, as well as new implementations and applications incorporating state-of-the-art machine learning techniques. Emphasis will be placed on systems that incorporate new sensors and the configuration of them. Review articles and works on performance evaluation and benchmark datasets are also solicited. For more detailed topics, please clink: mdpi.com/si/41949.

Guest Editors

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Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

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